OSRAM LE A P1MS **Datasheet**

Preliminary datasheet version

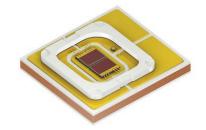




OSRAM OSTAR® Projection Power

LE A P1MS

OSRAM OSTAR Projection Power is a high luminance LED for projection applications.





Applications

- Projection & Display

Features

- Package: OSTAR High Power Projection
- Chip technology: Thinfilm
- Typ. Radiation: 120° (Lambertian emitter)
- Color: λ_{dom} = 614 nm (• amber)
- ESD: 2 kV acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)

Ordering Information

Type Luminous Flux $^{1)}$ Ordering Code $I_F = 4000 \text{ mA}$

LE A P1MS-RQRU-2 1210 ... 1800 lm Q65113A4265

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Maximum Ratings			
Parameter	Symbol		Values
Storage Temperature	T _{stg}	min.	-40 °C
		max.	100 °C
Junction Temperature	T _j	max.	125 °C
Forward Current	I _F	min.	200 mA
$T_j = T_{j,max}$	·	max.	5500 mA
Forward Current pulsed	 F pulse		5500 mA
D = 0.6; f = 240 Hz; $T_j = T_{j,max}$			
Surge Current	I _{FS}	max.	6900 mA
$t_{p} \le 50 \ \mu s; \ D = 0.1 \ ; \ T_{j} = T_{j,max}$. 0		
ESD withstand voltage	V_{ESD}		2 kV
acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)	200		
Reverse current 2)	I _R	max.	200 mA
Max. voltage difference anode-board, cathode-board	$ \Delta V_{a-b} , \Delta V_{c-b} $	max.	40 V

Characteristics

 T_{Board} = 25 °C; I_{F} = 4000 mA; f = 1000 Hz; D = 0.25

Parameter	Symbol	Values	
Peak Wavelength	λ_{peak}	typ.	622 nm
Dominant Wavelength 3)	λ_{dom}	min.	612 nm
	35	typ.	614 nm
		max.	618 nm
Spectral bandwidth at 50% I _{rel,max}	Δλ	typ.	17 nm
Viewing angle at 50% $\rm I_{_{\rm V}}$	2φ	typ.	120 °
Radiating surface	A _{color}	typ.	1.95 x 1.35
			mm²
Partial Flux acc. CIE 127:2007 4)	Ф _{Е/V, 120°}	typ.	0.77
$I_{\rm F} = 4000 \text{ mA}$	27, 120		
Forward Voltage 5)	V_{F}	min.	5.6 V
$I_{\rm F} = 4000 \text{ mA}$	·	typ.	6.0 V
		max.	7.0 V
Reverse voltage (ESD device)	$V_{_{RESD}}$	min.	45 V
Reverse voltage ²⁾	V_R	max.	1.2 V
I _R = 20 mA			
Real thermal resistance junction/solderpoint	$R_{thJSreal}$	typ.	1.3 K / W
Electrical thermal resistance junction/solderpoint with efficiency η_e = 22 %	R _{thJS elec.}	typ.	1.0 K / W



Brightness Groups

Group	Luminous Flux 1)	Luminous Flux 1)	
	$I_F = 4000 \text{ mA}$	$I_F = 4000 \text{ mA}$	
	min.	max.	
	Φ_{v}	Φ_{V}	
RQ	1210 lm	1300 lm	
RR	1300 lm	1400 lm	
RS	1400 lm	1500 lm	
RT	1500 lm	1640 lm	
RU	1640 lm	1800 lm	

Wavelength Groups

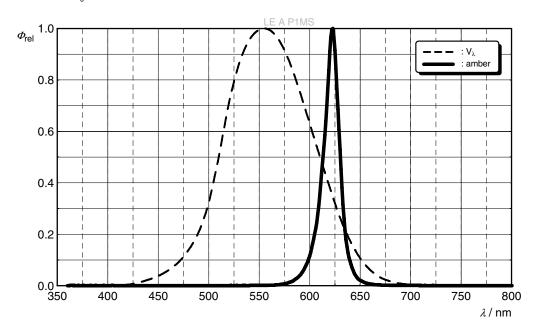
Group	Dominant Wavelength 3)	Dominant Wavelength 3)
	min.	max.
	λ_{dom}	$\lambda_{\sf dom}$
2	612 nm	618 nm

Group Name on Label

Example: RQ-2

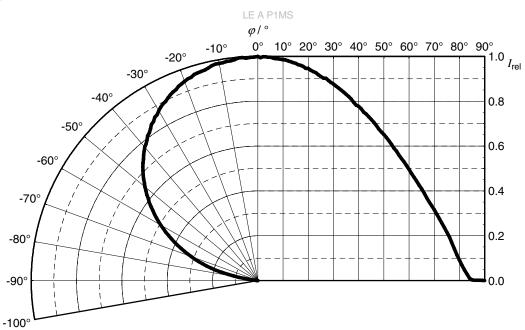
Brightness	Wavelength
RQ	2

$$\Phi_{rel}$$
 = f (λ); I_F = 4000 mA; T_J = 25 °C



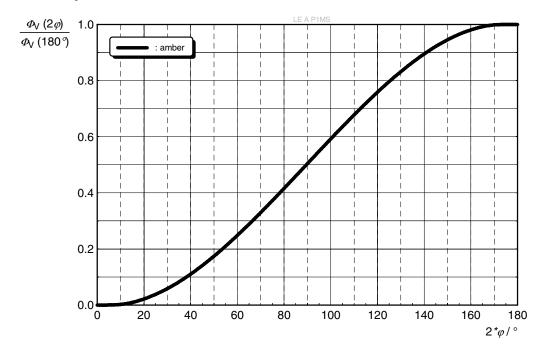
Radiation Characteristics 4)

 $I_{rel} = f (\phi); T_J = 25 °C$



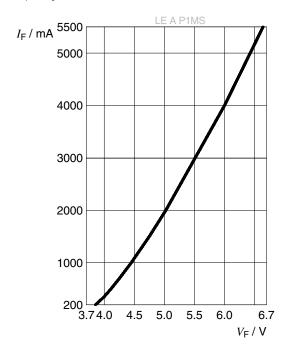
Relative Partial Flux 4)

 $\Phi_{_{V}}(2\phi)/\Phi_{_{V}}(180^{\circ}) = f(\phi); T_{_{J}} = 25 \,^{\circ}C$



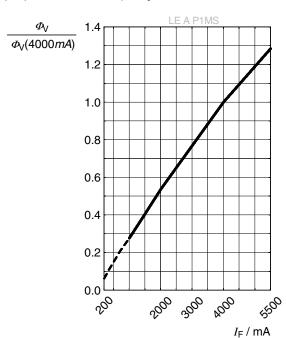
Forward current 4)

$$I_F = f(V_F); T_J = 25 \, ^{\circ}C$$



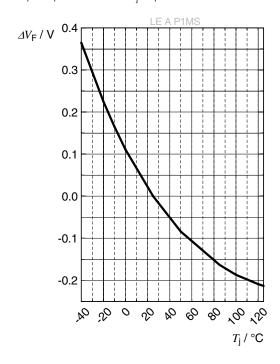
Relative Luminous Flux 4), 6)

$$\Phi_{V}/\Phi_{V}(4000 \text{ mA}) = f(I_{F}); T_{J} = 25 \text{ }^{\circ}\text{C}$$



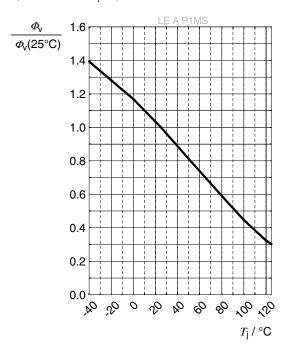
Forward Voltage 4)

$$\Delta V_F = V_F - V_F (25 \, ^{\circ}\text{C}) = f(T_i); \ I_F = 4000 \ \text{mA}$$



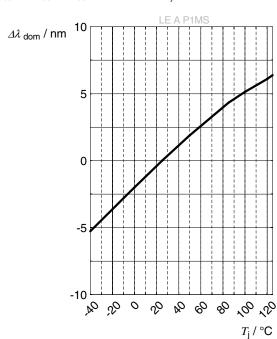
Relative Luminous Flux 4)

$$\Phi_{v}/\Phi_{v}(25 \text{ °C}) = f(T_{i}); I_{F} = 4000 \text{ mA}$$

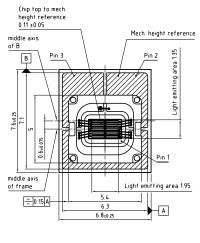


Dominant Wavelength 4)

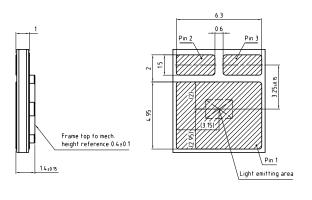
$$\Delta\lambda_{\text{dom}} = \lambda_{\text{dom}} - \lambda_{\text{dom}} (25 \text{ °C}) = f(T_j); I_F = 4000 \text{ mA}$$



Dimensional Drawing 7)







Pin 1: Substrate potential, isolated from Cathode and Anode

Pin 2: Cathod

Pin 3: Anode

C63062-A4436-A1-03

Further Information:

Approximate Weight: 380.0 mg

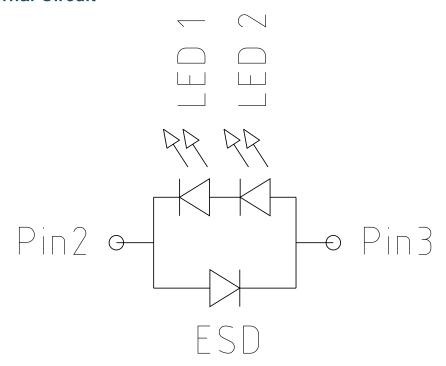
ESD advice: The device is protected by ESD device which is connected in parallel to the

Chip.

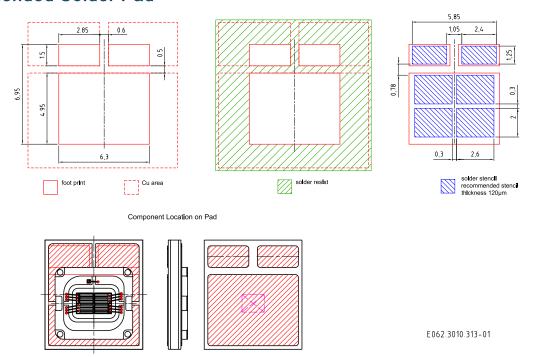
Notes: Package not suitable for any kind of wet cleaning or ultrasonic cleaning.

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Electrical Internal Circuit



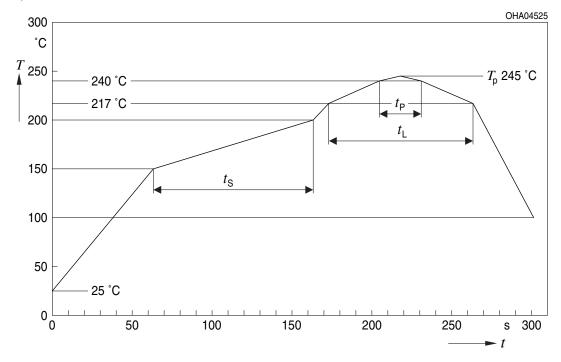
Recommended Solder Pad 7)



For protection during reflow soldering and handling a foil is attached to the device. The foil has to be removed before operation. For superior solder joint connectivity results we recommend soldering under standard nitrogen atmosphere. To ensure a high solder joint reliability and to minimize the risk of solder joint cracks, the customer is responsible to evaluate the combination of PCB board and solder paste material for his application.

Reflow Soldering Profile

Product complies to MSL Level 2 acc. to JEDEC J-STD-020E

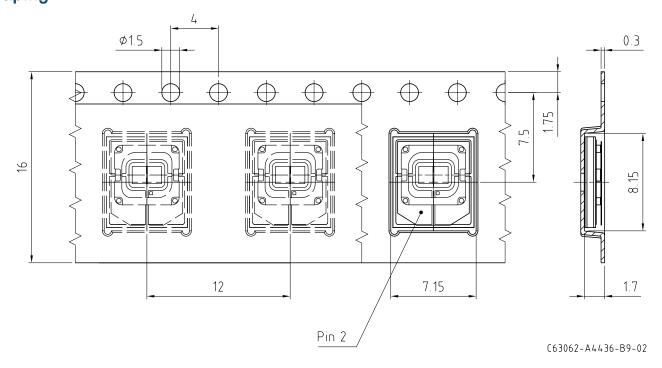


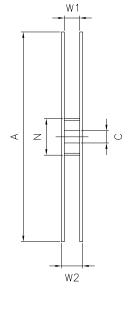
Profile Feature	Symbol	Pb-Free (SnAgCu) Assembly			Unit
		Minimum	Recommendation	Maximum	
Ramp-up rate to preheat*)	'		2	3	K/s
25 °C to 150 °C					
Time t _s	t _s	60	100	120	S
T_{Smin} to T_{Smax}					
Ramp-up rate to peak*)			2	3	K/s
T_{Smax} to T_{P}					
Liquidus temperature	T_{L}		217		°C
Time above liquidus temperature	$t_{\scriptscriptstyle \perp}$		80	100	S
Peak temperature	T _P		245	260	°C
Time within 5 °C of the specified peak temperature T _p - 5 K	t _P	10	20	30	S
Ramp-down rate* T _P to 100 °C			3	6	K/s
Time 25 °C to T _P				480	S

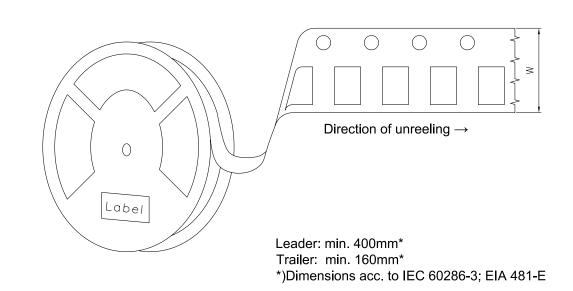
All temperatures refer to the center of the package, measured on the top of the component

^{*} slope calculation DT/Dt: Dt max. 5 s; fulfillment for the whole T-range

Taping 7)



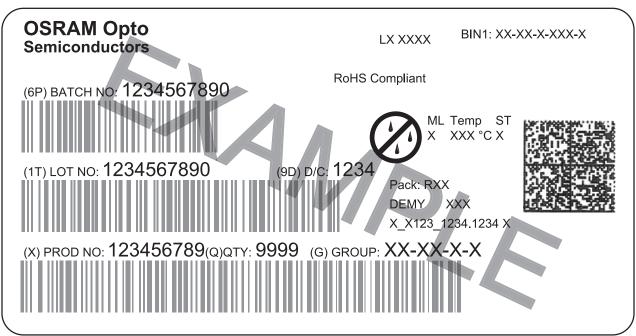




Reel Dimensions

Α	W	N_{\min}	W_1	$W_{2\text{max}}$	Pieces per PU
180 mm	16 + 0.3 / - 0.1 mm	60/100 mm	16.4 + 2 mm	22.4 mm	500

Barcode-Product-Label (BPL)



OHA04563

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Notes

The evaluation of eye safety occurs according to the standard IEC 62471:2006 (photo biological safety of lamps and lamp systems). Within the risk grouping system of this IEC standard, the device specified in this data sheet fall into the class exempt group (exposure time 10000 s). Under real circumstances (for exposure time, conditions of the eye pupils, observation distance), it is assumed that no endangerment to the eye exists from these devices. As a matter of principle, however, it should be mentioned that intense light sources have a high secondary exposure potential due to their blinding effect. When looking at bright light sources (e.g. headlights), temporary reduction in visual acuity and afterimages can occur, leading to irritation, annoyance, visual impairment, and even accidents, depending on the situation.

Subcomponents of this device contain, in addition to other substances, metal filled materials including silver. Metal filled materials can be affected by environments that contain traces of aggressive substances. Therefore, we recommend that customers minimize device exposure to aggressive substances during storage, production, and use. Devices that showed visible discoloration when tested using the described tests above did show no performance deviations within failure limits during the stated test duration. Respective failure limits are described in the IEC60810.

For further application related information please visit www.osram-os.com/appnotes

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Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

Product and functional safety devices/applications or medical devices/applications

Our components are not developed, constructed or tested for the application as safety relevant component or for the application in medical devices.

Our products are not qualified at module and system level for such application.

In case buyer - or customer supplied by buyer - considers using our components in product safety devices/ applications or medical devices/applications, buyer and/or customer has to inform our local sales partner immediately and we and buyer and /or customer will analyze and coordinate the customer-specific request between us and buyer and/or customer.

Glossary

- Brightness: Brightness values are measured during a pulse train of 100 ms with a pulse width of 250 us and a frequencey of 1 kHz, with an internal reproducibility of +/- 8 % and an expanded uncertainty of +/- 11 % (acc. to GUM with a coverage factor of k = 3). The peak brightness is calculated according to the pulse duration and frequency.
- Reverse Operation: This product is intended to be operated applying a forward current within the specified range. Applying any continuous reverse bias or forward bias below the voltage range of light emission shall be avoided because it may cause migration which can change the electro-optical characteristics or damage the LED.
- Wavelength: The wavelength is measured during a pulse train of 100 ms with a pulse width of 250 µs and a frequencey of 1 kHz, with an internal reproducibility of ± 0,5 nm and an expanded uncertainty of ± 1 nm (acc. to GUM with a coverage factor of k=3).
- Typical Values: Due to the special conditions of the manufacturing processes of semiconductor devices, the typical data or calculated correlations of technical parameters can only reflect statistical figures. These do not necessarily correspond to the actual parameters of each single product, which could differ from the typical data and calculated correlations or the typical characteristic line. If requested, e.g. because of technical improvements, these typ. data will be changed without any further notice.
- Forward Voltage: The forward voltage is measured during a pulse of typical 250 µs, with an internal reproducibility of +/- 0,05 V and an expanded uncertainty of +/- 0,1 V (acc. to GUM with a coverage factor of k=3).
- 6) Characteristic curve: In the range where the line of the graph is broken, you must expect higher differences between single devices within one packing unit.
- Tolerance of Measure: Unless otherwise noted in drawing, tolerances are specified with ±0.1 and dimensions are specified in mm.
- Tape and Reel: All dimensions and tolerances are specified acc. IEC 60286-3 and specified in mm.

Revision History

Version	Date	Change
0.0	2022-08-01	Initial Version
0.1	2022-09-26	Characteristics

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